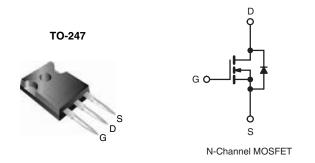


Vishay Siliconix

## **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500	500		
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	0.23		
Q <sub>g</sub> (Max.) (nC)	120			
Q <sub>gs</sub> (nC)	32			
Q <sub>gd</sub> (nC)	52			
Configuration	Single			



### **FEATURES**

• Low Gate Charge Qq Results in Simple Drive Requirement



 Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Lead (Pb)-free Available

### **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching

### **TYPICAL SMPS TOPOLOGIES**

- Full Bridge Converters
- Power Factor Correction Boost

ORDERING INFORMATION		
Package	TO-247	
Lead (Pb)-free	IRP22N50APbF	
	SiHFP22N50A-E3	
SnPb	IRP22N50A	
	SiHFP22N50A	

<b>ABSOLUTE MAXIMUM RATINGS</b> T	<sub>C</sub> = 25 °C, unless otherw	rise noted			
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		$V_{DS}$	500	V	
Gate-Source Voltage	$V_{GS}$	± 30	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \		
Continuous Drain Current	$V_{GS}$ at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$		22	А	
	$T_C = 100 ^{\circ}C$	I <sub>D</sub>	14		
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	88			
Linear Derating Factor		2.2	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	1180	mJ		
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	22	Α		
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	28	mJ		
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	$P_{D}$	277	W	
Peak Diode Recovery dV/dtc	dV/dt	4.8	V/ns		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s	-	300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	6-32 OF IVI3 SCIEW		1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting  $T_J$  = 25 °C, L = 4.87 mH,  $R_G$  = 25  $\Omega,\,I_{AS}$  = 22 A (see fig. 12).
- c.  $I_{SD} \leq 22$  A,  $dI/dt \leq 190$  A/µs,  $V_{DD} \leq V_{DS}, \, T_{J} \leq 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP22N50A, SiHFP22N50A

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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.45	

PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static		1					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	i	0.55	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	٧
Gate-Source Leakage	I <sub>GSS</sub>	\	V <sub>GS</sub> = ± 30 V		-	± 100	nA
		V <sub>DS</sub> =	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 V	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	i	-	250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 13 A <sup>b</sup>	ı	-	0.23	Ω
Forward Transconductance	9fs	V <sub>DS</sub> =	50 V, I <sub>D</sub> = 13 A <sup>b</sup>	12	-	-	S
Dynamic		1				•	
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 \text{ V}, \\ V_{DS} = 25 \text{ V},$		3450	-	-
Output Capacitance	C <sub>oss</sub>	,			513	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		i	27	-	
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 1.0 V, f = 1.0 MHz		4935		pF
			V <sub>DS</sub> = 400 V, f = 1.0 MHz		137		
Effective Output Capacitance	C <sub>oss</sub> eff.		V <sub>DS</sub> = 0 V to 400 V <sup>c</sup>		264		
Total Gate Charge	Qg			-	-	120	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 22 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	-	-	32	
Gate-Drain Charge	$Q_{gd}$		ooo ng. o ana ro	-	-	52	
Turn-On Delay Time	t <sub>d(on)</sub>			-	26	-	
Rise Time	t <sub>r</sub>	Von -	V 250 V I 20 A		94	-	1
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 250 \text{ V, } I_D = 22 \text{ A,}$ $R_G = 4.3 \ \Omega, \ R_D = 11 \ \Omega, \text{ see fig. } 10^b$		-	47	-	- ns -
Fall Time	t <sub>f</sub>			-	47	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	22	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	88	_ ^
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 22\text{A},  V_{GS} = 0  V^b$		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 22 A, dI/dt = 100 A/μs <sup>b</sup>		-	570	850	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	6.1	9.2	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L				L <sub>D</sub> )	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80 %  $V_{DS}$ .





### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

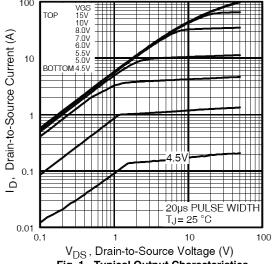


Fig. 1 - Typical Output Characteristics

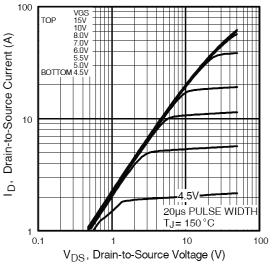


Fig. 2 - Typical Output Characteristics

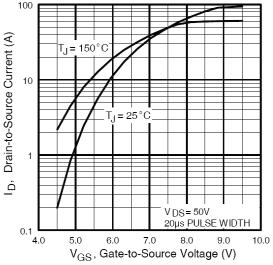


Fig. 3 - Typical Transfer Characteristics

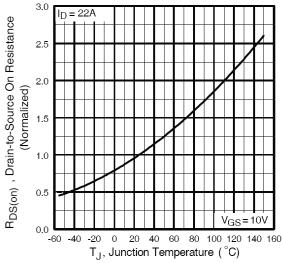


Fig. 4 - Normalized On-Resistance vs. Temperature

# IRFP22N50A, SiHFP22N50A

# Vishay Siliconix



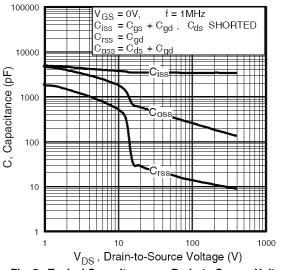


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

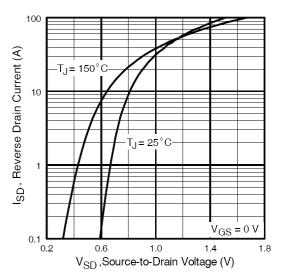


Fig. 7 - Typical Source-Drain Diode Forward Voltage

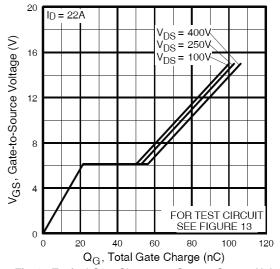


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

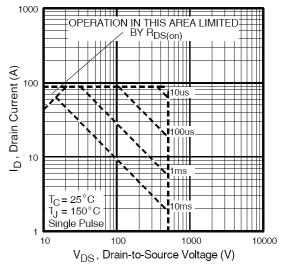


Fig. 8 - Maximum Safe Operating Area





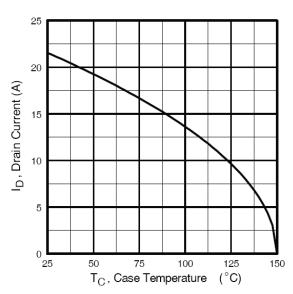


Fig. 9 - Maximum Drain Current vs. Case Temperature

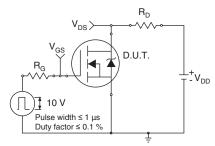


Fig. 10a - Switching Time Test Circuit

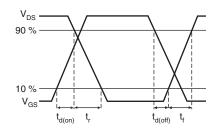


Fig. 10b - Switching Time Waveforms

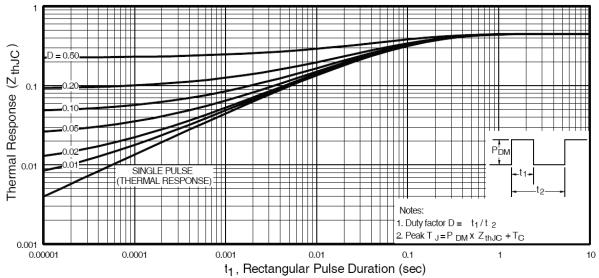


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

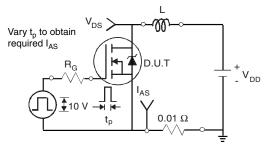


Fig. 12a - Unclamped Inductive Test Circuit

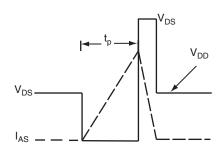


Fig. 12b - Unclamped Inductive Waveforms

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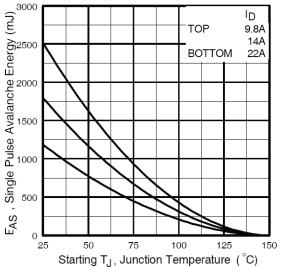


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

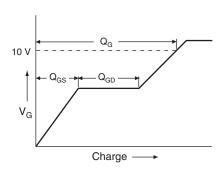


Fig. 13a - Basic Gate Charge Waveform

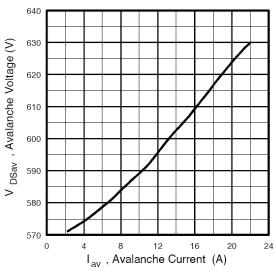


Fig. 12d - Typical Drain-to-Source Voltage vs.
Avalanche Current

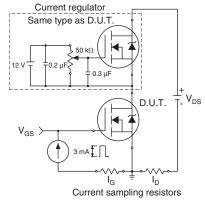
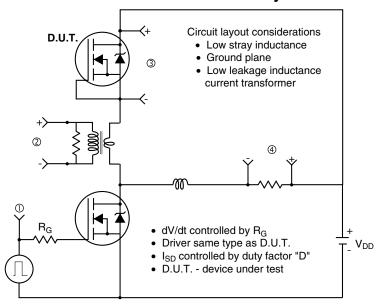
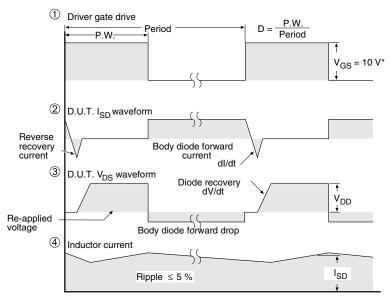


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit





\*  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel

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